

<b>Notice of References Cited</b>	Application/Control No. 10/749,356	Applicant(s)/Patent Under Reexamination AHN ET AL.	
	Examiner Tan T. Nguyen	Art Unit 2827	Page 1 of 1

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*	C	US-5,251,171	10-1993	Yamauchi, Yoshimitsu	365/185.08
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**NON-PATENT DOCUMENTS**

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